

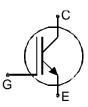
IGBT³ Chip

FEATURES:

- 600V Trench & Field Stop technology
- low V_{CE(sat)}
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

- power module
- Applications:
- drives



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC100T60R3	600V	200A	9.73 x 10.23 mm ²	sawn on foil	Q67050- A4345-A101

MECHANICAL PARAMETER:

	0.70 10.00			
Raster size	9.73 x 10.23			
Emitter pad size	(4.256 x 1.938) x 4	mm ²		
	(4.256 x 2.356) x 4			
Gate pad size	1.615 x 0.817			
Area total / active	99.5 / 80.1			
Thickness	70	μm		
Wafer size	150	mm		
Flat position	90	deg		
Max. possible chips per wafer	121 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm AlSiCu			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500µm			
Reject ink dot size	Ø 0.65mm ; max 1.2mm			
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit	
Collector-emitter voltage, T_j = 25 °C	V _{CE}	600	V	
DC collector current, limited by T_{jmax}	I _C	1)	А	
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	600	А	
Gate emitter voltage	V _{GE}	±20	V	
Operating junction and storage temperatur	T _j , T _{stg}	-40 +175	°C	
SC data, V_{GE} = 15V, V_{CC} = 360V	Tvj = 150°C	tp	6	μs
50 data, v _{GE} = 15v, v _{CC} = 500v	Tvj = 25°C	ίΡ	8	μ0

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
i arameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I _C = 4mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V_{GE} =15V, I _C =200A	1.05	1.45	1.85	V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C{=}3200\mu A$, $V_{GE}{=}V_{CE}$	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V , V_{GE} =0V			10.1	μA
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$				nA
Integrated gate resistor	R _{Gint}			2		Ω

ELECTRICAL CHARACTERISTICS (verified by design/characterization):

Parameter	Symbol	Conditions	Value			Unit
Falameter			min.	typ.	max.	Unit
Input capacitance	Ciss	V _{CE} =25V,		12335		pF
Output capacitance	Coss	$V_{\rm GE}=0V$,		769		
Reverse transfer capacitance	Crss	f=1MHz		366		

SWITCHING CHARACTERISTICS (verified by design/characterization), inductive load

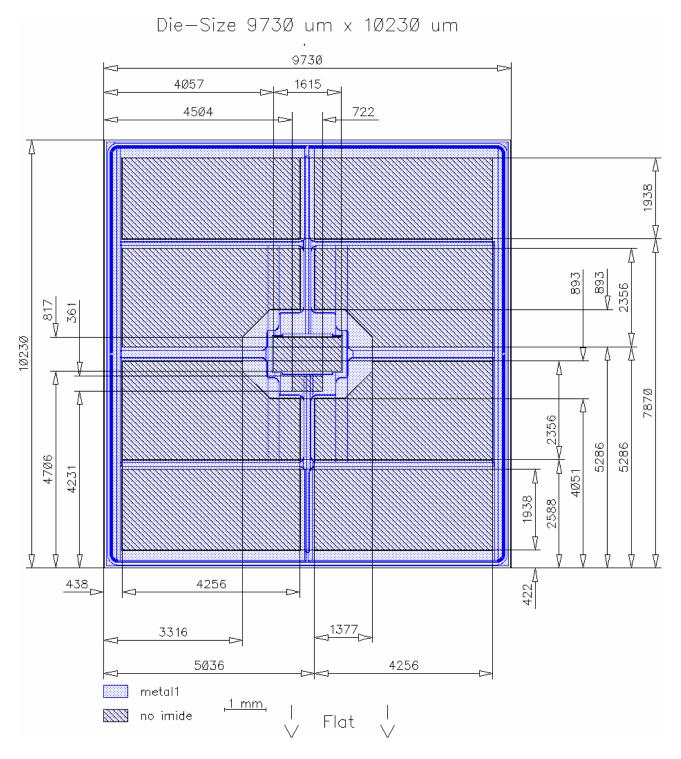
Parameter	Symbol	Conditions	Value ²⁾			Unit
Falameter			min.	typ.	max.	
Turn-on delay time	t _{d(on)}	<i>T</i> _j =125°C		145		ns
Rise time	t _r	V _{CC} =300V,		30		
Turn-off delay time	t _{d(off)}	/ _C =200A, / _{GE} =-15/15V,		340		
Fall time	t _f	$R_{\rm G}=2\Omega$		60		

²⁾ values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	
device data sheet	

DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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